

Notice of References Cited	Application/Control No. 10/561,378		Applicant(s)/Patent Under Reexamination TAKEI, RYUICHI	
	Examiner JESSE A. ELBIN		Art Unit 2615	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,197,091 A	03-1993	Takagi et al.	455/575.7
*	B	US-5,883,966 A	03-1999	Kubo, Masato	381/386
*	C	US-2002/0061115 A1	05-2002	Chung et al.	381/398
*	D	US-2003/0112993 A1	06-2003	Teshima et al.	381/396
*	E	US-2005/0014534 A1	01-2005	Hareng et al.	455/567
*	F	US-6,912,287 B1	06-2005	Fukumoto et al.	381/151
*	G	US-2005/0176459 A1	08-2005	Fukuda, Mikio	455/550.1
*	H	US-2006/0113932 A1	06-2006	Mori et al.	318/114
*	I	US-2006/0262954 A1	11-2006	Lee et al.	381/380
*	J	US-2006/0286998 A1	12-2006	Fukuda, Mikio	455/550.1
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/054425	07-2002	WO	Feil, Henry	H01H 13/70
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.